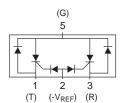
# **Battrax Dual Negative SLIC Protector**



This solid state Battrax protection device is referenced to a negative voltage source. Its dual-chip package also includes internal diodes for transient protection from positive surge events.

For a diagram of a Battrax application, see Figure 3.27.

### **Electrical Parameters**

Part Number *	V <sub>DRM</sub> Volts	V <sub>S</sub> Volts	V <sub>T</sub> Volts	V <sub>F</sub> Volts	I <sub>DRM</sub> μAmps	I <sub>GT</sub> mAmps	I <sub>T</sub> Amps	I <sub>H</sub> mAmps	C <sub>O</sub> pF
B1101U_	-V <sub>REF</sub>   +  -1.2V	-V <sub>REF</sub>   +  -10V	4	5	5	100	1	100	50
B1161U_	-V <sub>REF</sub>   +  -1.2V	-V <sub>REF</sub>   +  -10V	4	5	5	100	1	160	50
B1201U_	-V <sub>REF</sub>   +  -1.2V	-V <sub>REF</sub>   +  -10V	4	5	5	100	1	200	50

<sup>\*</sup> For individual "UA" and "UC" surge ratings, see table below.

## General Notes:

- All measurements are made at an ambient temperature of 25 °C. IPP applies to -40 °C through +85 °C temperature range.
- IPP is a repetitive surge rating and is guaranteed for the life of the product.
- I<sub>PP</sub> ratings assume a V<sub>REF</sub> = -48 V.
- V<sub>DRM</sub> is measured at I<sub>DRM</sub>.
- V<sub>S</sub> is measured at 100 V/µs.
- Off-state capacitance is measured at 1 MHz with a 2 V bias and is a typical value. "UC" product is approximately 2x the listed value.
- $V_{REF}$  maximum value for the B1101, B1161, and/or B1201 is -200 V.

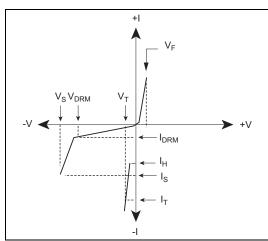
# **Surge Ratings**

Series	l <sub>PP</sub> 2x10 μs Amps	I <sub>PP</sub> 8x20 μs Amps	I <sub>PP</sub> 10x160 μs Amps	I <sub>PP</sub> 10x560 μs Amps	I <sub>PP</sub> 10x1000 μs Amps	I <sub>TSM</sub> 60 Hz Amps	di/dt Amps/µs
Α	150	150	90	50	45	20	500
С	500	400	200	120	100	50	500

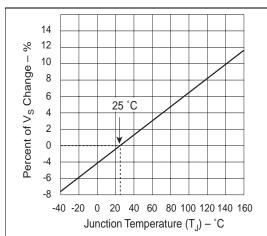
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### **Thermal Considerations**

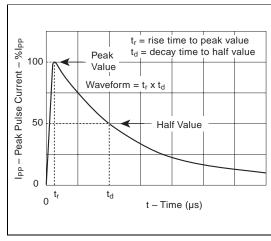
Package	Symbol	Parameter	Value	Unit
Modified MS-013	TJ	Operating Junction Temperature Range	-40 to +125	°C
1 2 3	Ts	Storage Temperature Range	-65 to +150	°C
	$R_{ hetaJA}$	Thermal Resistance: Junction to Ambient	60	°C/W



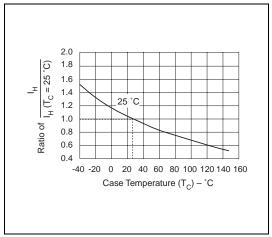
V-I Characteristics



Normalized V<sub>S</sub> Change versus Junction Temperature



 $t_{\rm r} \ x \ t_{\rm d}$  Pulse Wave-form



Normalized DC Holding Current versus Case Temperature